Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2158	711/141.ccls. or 711/144-146.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:02
L2	1380	709/213.ccls. or 709/216.ccls. or 709/253.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:02
L3	92	(select\$3 or mutiplex\$3)same(snoop\$3 same director\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 09:47
L4	10	3 same (bandwidth or (amount near3 data))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:33
L5	82	multicast same snoop\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:12
L6	53	multicast with snoop\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:12
L7	1	3 and 6 US-PGPU USPAT; USOCR; EPO; JPO DERWEN IBM_TDI		OR	ON	2004/12/03 10:14
L8	0	(broad near2 cast) with snoop\$3 US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB		OR	ON	2004/12/03 10:15

L9	307	(broadcast\$3) with snoop\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:15
L10	3	6 same 9	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:15
L11	0	select\$3 same broadcast same (point adj2 to adj2 point)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:35
L12	317	select\$5 same broadcast same ((point adj2 to adj2 point) or "point-to-point")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2004/12/03 10:35
L13	7538	cache with (coheren\$3 or consisten\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:37
L14	16	12 and 13	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:54
L15	16	14 and bandwidth	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 10:58
L16	7	15 and (@ad<="20010314" or @rlad<="20010314")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:05

L17	3957	709/213.ccls. or 709/216.ccls. or 709/253.ccls. or 709/230.ccls. or 709/245.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:02
L18	2656	711/141.ccls. or 711/144-146.ccls. or 711/3.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:03
L19	6545	17 or 18	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:03
L20	45	3 and 19	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON .	2004/12/03 11:03
L21	3	20 and (10 or 12)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:04
L22	3	21 and bandwidth	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:05
L23	1	22 and (@ad<="20010314" or @rlad<="20010314")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:06
L24	1	23 and 13	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:05

						
L25	80	3 and 13	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:06
L26	42	19 and 25	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:06
L27	36	26 and (@ad<="20010314" or @rlad<="20010314")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON .	2004/12/03 11:06
L28	1	27 and 5	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:06
L29	0	27 and 12	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:07
L30	21	27 and bandwidth	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:15
L31	407	martin-milo\$.in. or sorin-daniel\$.in. or hill-mark\$.in. or wood-david\$.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:16
L32	1	3 and 31	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:16

L33	1	6 and 31	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:17
L34	35	13 and 31	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:17
L35	1	12 and 34	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/03 11:17

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